03500.015716.1

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application	on of:)	Daniero Errania de A	. Cla alamala and
NOBUKO YAMAMOTO ET AL. Div. of Application No.: 09/942,662		Previous Examiner: A. Chakrabarti)		
		: Previous Group Art Ur)		Jnit: 1634
Filed: Herewit	h	;		
REAC	HOD FOR EXAMINING CTIVITY AND METHOD DETECTING A COMPLEX	;) . ;	June 27, 2003	<i>(</i>

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. In accordance with 37 C.F.R. §1.98(d), copies of the documents available in Application No. 09/942,662, from which the present application claims benefit under 35 U.S.C. § 120, are not enclosed.

CONCLUSION

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicants' undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

Respectfully submitted,

Registration No. 48,512

FITZPATRICK, CELLA, HARPER & SCINTO

30 Rockefeller Plaza
New York, New York 10112-3801
Facsimile: (212) 218-2200

APPLICATION NO. FORM PTO 1449 (modified) ATTY DOCKET NO. 03500.015716.1 Div. of 09/942,662 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE **APPLICANT** Nobuko Yamamoto et al. LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) GROUP **FILING DATE** N.Y.A. Herewith U.S. PATENT DOCUMENTS *EXAMINER INITIAL DOCUMENT NUMBER FILING DATE SUBCLASS DATE NAME CLASS 5,445,934 08/29/95 Fodor et al. 435 6 5,405,783 04/11/95 Pirrung et al. 518 436 5,601,980 02/11/97 Gordon et al. 435 6 2002/0168648 A1 11/14/02 Yamamoto et al. 435 6 2002/0106667 A1 08/08/02 Yamamoto et al. 435 6 5,601,980 02/11/97 Gordon et al. 435 6 5,891,630 04/06/99 Eggers et al. 435 6 5,688,642 11/18/97 435 6 Chrisey et al. 5,807,942 526 238.1 09/15/98 Sasaki et al. FOREIGN PATENT DOCUMENTS TRANSLATION YES/NO/ OR ABSTRACT DOCUMENT NUMBER **SUBCLASS** DATE COUNTRY CLASS **EP** 0 373 203 B1 08/31/94 Europe

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

Mark Schena et al, "Quantitative Monitoring of Gene Expression Patterns with a Complementary DNA Microarray," 270 Science 467-470 (1995).

EXAMINER

DATE CONSIDERED

EXAMINER:	Initial if reference considered,	whether or not citation is	in conformance with MPEI	609; Draw line through	h citation if not in conformat	nce and not considered.	Include copy
of this form wi	th next communication to appli	cant.					

Sheet	1	of	1
SHEEL		OI.	